MOSFET - N-Channel Shielded Gate PowerTrench® 150 V, 14 mΩ, 61 A

NTMFS015N15MC

Features

- Small Footprint (5 x 6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low QG and Capacitance to Minimize Driver Losses
- 100% UIL Tested
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS

Typical Applications

- Synchronous Rectification
- AC-DC and DC-DC Power Supplies
- AC-DC Adapters (USB PD) SR
- Load Switch

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parar	neter		Symbol	Value	Unit
Drain-to-Source Voltage		V_{DSS}	150	V	
Gate-to-Source Voltage	€		V_{GS}	±20	V
Continuous Drain Current R _{θJC} (Note 2)	Steady	T 05°C	I _D	61	Α
Power Dissipation $R_{\theta JC}$ (Note 2)	State	T _C = 25°C	P _D	108.7	W
Continuous Drain Current $R_{\theta,JA}$ (Notes 1, 2)	Steady State	T _A = 25°C	I _D	9.2	Α
Power Dissipation R _{θJA} (Notes 1, 2)	State	State	P _D	2.5	W
Pulsed Drain Current	T _C = 25°	C, t _p = 100 μs	I _{DM}	302	Α
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150	°C	
Single Pulse Drain-to-Source Avalanche Energy (I _L = 10 A _{pk} , L = 3 mH)		E _{AS}	150	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

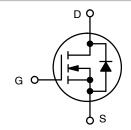
- 1. Surface-mounted on FR4 board using a 1 in 2 , 2 oz. Cu pad.
- 2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.



ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
150 V	14 mΩ @ 10 V	61 A



N-CHANNEL MOSFET



MARKING DIAGRAM



1515MC = Specific Device Code = Assembly Location

Υ = Year W = Work Week ZΖ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS015N15MC	Power 56	3000 / Tape
(Pb-Free/Halogen Free)	(PQFN8)	& Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

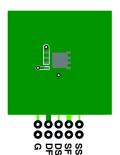
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ hetaJC}$	1.15	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)	$R_{ hetaJA}$	50	

Parameter	Symbol	Test Condit	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS					1	<u>I</u>	<u>.</u>
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D =	250 μΑ	150			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /	I _D = 250 μA, ref to 25°C			109		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 120 V	T _J = 25°C			1.0	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS					•	•	
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$: 162 μA	2.5		4.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	I _D = 162 μA, ref	to 25°C		-7.6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D	= 29 A		10.2	14	mΩ
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 8 V, I _D	= 15 A		11.1	16.2	mΩ
Forward Transconductance	9FS	V _{DS} = 10 V, I _D = 29 A			56		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE				•	•	
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 75 V			2120		
Output Capacitance	Coss				595		pF
Reverse Transfer Capacitance	C _{RSS}				10.5		
Gate-Resistance	R_{G}				0.6	1.2	Ω
Total Gate Charge	Q _{G(TOT)}				27		
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 10 \text{ V}, V_{DS} = 75 \text{ V}; I_D = 29 \text{ A}$			7		nC
Gate-to-Source Charge	Q_{GS}				11		
Gate-to-Drain Charge	Q_{GD}				4		
Plateau Voltage	V_{GP}				5.5		V
Output Charge	Q _{OSS}	V _{DD} = 75 V, V _G	_{iS} = 0 V		66		nC
SWITCHING CHARACTERISTICS (Note 3)					•	•	•
Turn-On Delay Time	t _{d(ON)}				16		
Rise Time	t _r	V _{GS} = 10 V, V _{DD}	n = 75 V,		5		1
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 29 \text{ A}, R_G = 6 \Omega$			21		ns
Fall Time	t _f				4		1
DRAIN-SOURCE DIODE CHARACTERISTIC	s						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 29 A	T _J = 25°C		0.86	1.2	V
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, V _{DD}	= 75 V		49		ns
Reverse Recovery Charge	Q _{RR}	$dI_S/dt = 300 \text{ A/}\mu\text{s}, I_S = 29 \text{ A}$			197		nC
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, V _{DD}	= 75 V		34		ns
Reverse Recovery Charge	Q _{RR}	$dI_{S}/dt = 1000 \text{ A}/\mu\text{s}, I_{S} = 29 \text{ A}$			345		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

- Switching characteristics are independent of operating junction temperatures.
 R_{θJA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR-4 material. R_{θCA} is determined by the user's board design.



a) 50°C/W when mounted on a 1 in² pad of 2 oz copper.



b) 125°C/W when mounted on a minimum pad of 2 oz copper.

TYPICAL CHARACTERISTICS

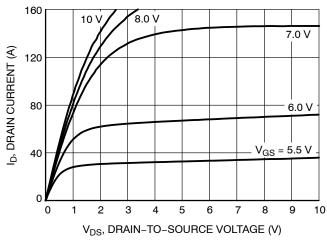


Figure 1. On-Region Characteristics

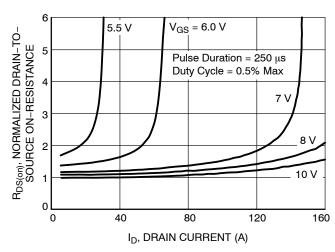


Figure 2. Normalized On–Resistance vs. Drain Current and Gate Voltage

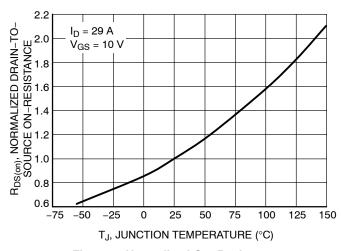


Figure 3. Normalized On–Resistance vs. Junction Temperature

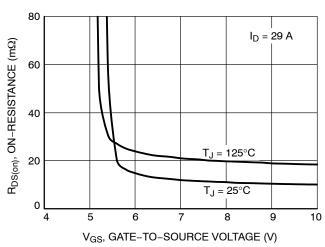


Figure 4. On-Resistance vs. Gate-to-Source Voltage

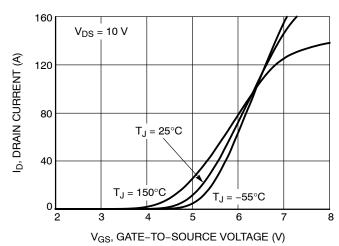


Figure 5. Transfer Characteristics

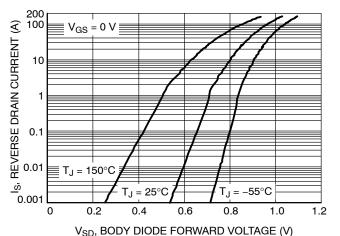


Figure 6. Source-to-Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS

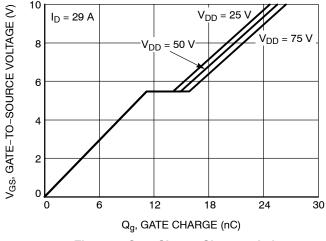


Figure 7. Gate Charge Characteristics

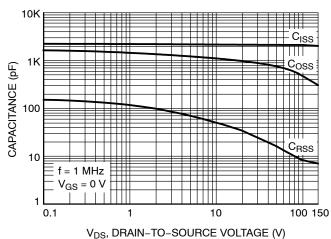


Figure 8. Capacitance vs. Drain-to-Source

Voltage

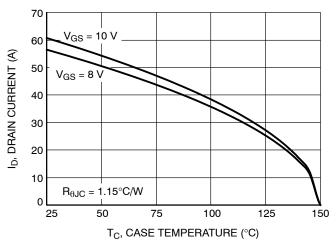


Figure 9. Drain Current vs. Case Temperature

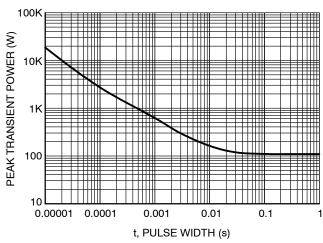


Figure 10. Peak Power

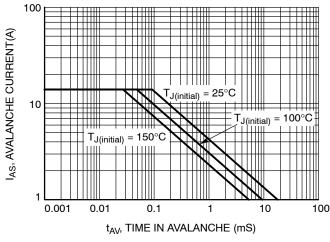


Figure 11. Unclamped Inductive Switching Capability

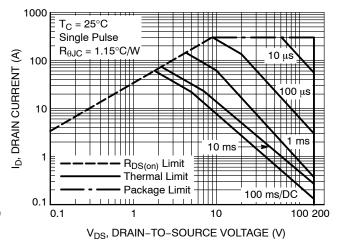


Figure 12. Forward Bias Safe Operating Area

TYPICAL CHARACTERISTICS

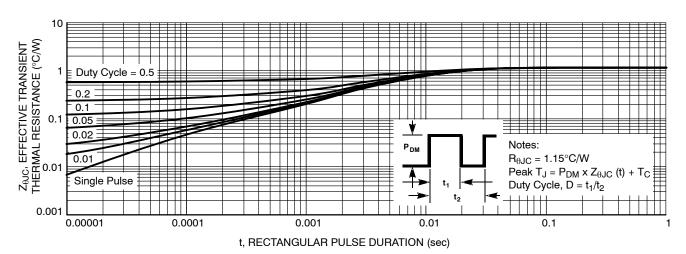
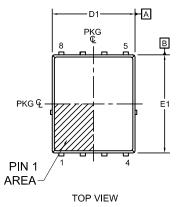
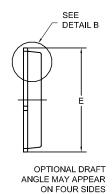


Figure 13. Transient Thermal Impedance



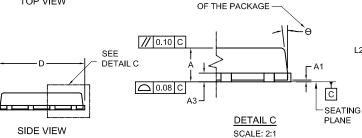
DATE 06 JUL 2021

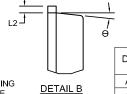




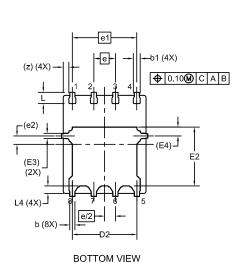
NOTES:

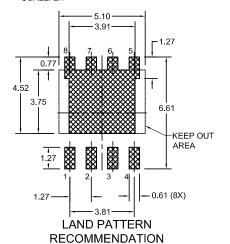
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.





SCALE: 2:1





*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

DIM	MILLIMETERS			
DIIVI	MIN.	NOM.	MAX.	
Α	0.90	1.00	1.10	
A1	0.00	-	0.05	
b	0.21	0.31	0.41	
b1	0.31	0.41	0.51	
А3	0.15	0.25	0.35	
D	4.90	5.00	5.20	
D1	4.80	4.90	5.00	
D2	3.61	3.82	3.96	
Е	6.05	6.15	6.25	
E1	5.70	5.80	5.90	
E2	3.38	3.48	3.78	
E3	(0.30 REF		
E4	(0.52 REF		
е	,	1.27 BSC	;	
e/2	(0.635 BS	С	
e1	;	3.81 BSC	;	
e2	0.50 REF			
L	0.51	0.66	0.76	
L2	0.05	0.18	0.30	
L4	0.34	0.44	0.54	
z	0.34 REF			
θ	0°	-	12°	

DOCUMENT NUMBER:	98AON13655G	Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	PQFN8 5X6, 1.27P	•	PAGE 1 OF 1

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by ON Semiconductor manufacturer:

Other Similar products are found below:

IRFD120 JANTX2N5237 BUK455-60A/B MIC4420CM-TR VN1206L NDP4060 SI4482DY IPS70R2K0CEAKMA1 SQD23N06-31L-GE3
TK16J60W,S1VQ(O 2SK2614(TE16L1,Q) DMN1017UCP3-7 DMN1053UCP4-7 SQJ469EP-T1-GE3 NTE2384 DMC2700UDMQ-7
DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 DMP22D4UFO-7B DMN1006UCA6-7 DMN16M9UCA6-7
STF5N65M6 IRF40H233XTMA1 STU5N65M6 DMN6022SSD-13 DMN13M9UCA6-7 DMTH10H4M6SPS-13 DMN2990UFB-7B
IPB80P04P405ATMA2 2N7002W-G MCAC30N06Y-TP MCQ7328-TP BXP7N65D BXP4N65F AOL1454G WMJ80N60C4 BXP2N20L
BXP2N65D BXT1150N10J BXT1700P06M TSM60NB380CP ROG RQ7L055BGTCR DMNH15H110SK3-13 SLF10N65ABV2
BSO203SP BSO211P IPA60R230P6 IPA60R460CE